

Notice of References Cited

Application/Control No.

10/530,402

Applicant(s)/Patent Under
Reexamination
EYTAN ET AL.

Examiner

THOMAS D. ALUNKAL

Art Unit

2627

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,129,006	10-2006	Hesselink et al.	430/1
*	B	US-6,366,542	04-2002	Kojima et al.	369/44.23
*	C	US-6,091,549	07-2000	McDonald et al.	359/637
*	D	US-2002/0060959	05-2002	Shiono et al.	369/44.24
*	E	US-5,303,221	04-1994	Maeda et al.	369/112.1
*	F	US-2003/0067861	04-2003	Kimura, Tohru	369/112.26
*	G	US-6,721,259	04-2004	Yamamoto et al.	369/112.26
*	H	US-6,064,529	05-2000	McDonald et al.	359/637
*	I	US-6,288,804	09-2001	Daiber et al.	359/15
*	J	US-6,291,132	09-2001	Glushko et al.	430/270.15
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.